ROHDE&SCHWARZ

Make ideas real



R&S®NGU401 versus Keithley 2401





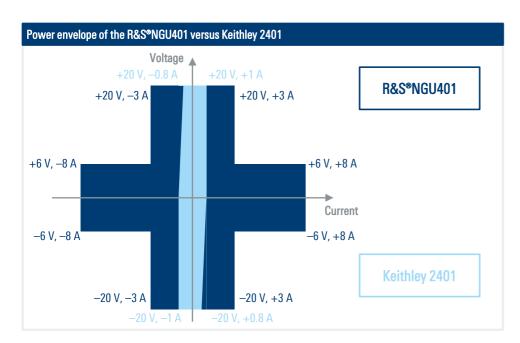
What sets this source measure unit apart?

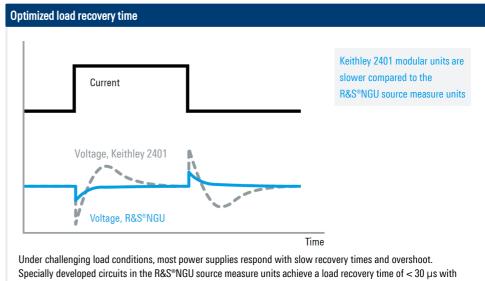
- ▶ Minimum residual ripple and noise to supply interference free voltage to sensitive DUTs
- ► Fast regulation of output voltage with minimum overshoot and very fast load recovery time
- ► Acquisition rate of up to 500 ksample/s to capture extremely fast variations in voltage or current
- ► Voltage priority and current priority mode
- ► High-capacitance mode
- ► Modulation input

| Your benefit | Features |
|--|---|
| Minimal overshoot from abrupt load changes | ▶ Optimized load recovery time of < 30 µs ▶ Handles abrupt load changes from a few nA to the ampere range without creating voltage drops or overshoots |
| Capture fast variations in voltage/current | Acquisition rate of up to 500 ksample/s Voltage and current results available every 2 µs |
| Supply positive and negative voltages and currents | ► Four-quadrant operation allows the R&S®NGU401 to act as a source or sink in both polarities ► This enables tasks such as measuring the forward and reverse characteristics of semiconductor devices in a single test operation without having to make changes to the circuit |
| Can act as an AC source | ► The R&S®NGU401 source measure unit provides a modulation input to connect an arbitrary generator, for instance. The output follows the modulation input signal, enabling the instrument to act as an AC source and be used to simulate glitches and unstable conditions |

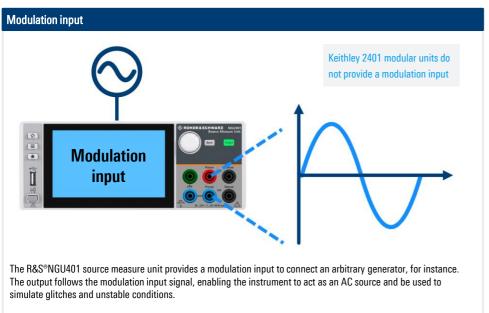
| R&S®NGU401 | Keithley 2401 |
|---------------------------------|---|
| ±20 V / 8 A / 60 W | ±20 V / 1 A / 20 W |
| < 500 µV (meas.) | not specified |
| < 1 mA (meas.) | not specified |
| < 30 µs (meas.) | not specified |
| < 100 µs / < 100 µs | not specified |
| voltage, current, power, energy | voltage, current, resistance |
| 2/6 | 3/7 |
| 1 μV / 100 pA | 1 μV / 10 pA |
| $< 0.02 \% + 500 \mu V$ | < 0.012 % + 300 µV |
| < 0.025 % + 15 nA | < 0.0295 % + 300 pA |
| 500 ksample/s (2 µs) | 1700 readings/s at 4 1/2 digits |
| QuickArb (100 µs) | test sequencer (500 µs) |
| OVP, OCP, OPP, OTP | OTP |
| optional | yes |
| yes (470 µF) | no |
| yes | no |
| yes | no |
| | ±20 V / 8 A / 60 W < 500 μV (meas.) < 1 mA (meas.) < 30 μs (meas.) < 100 μs / < 100 μs voltage, current, power, energy 2 / 6 1 μV / 100 pA < 0.02 % + 500 μV < 0.025 % + 15 nA 500 ksample/s (2 μs) QuickArb (100 μs) OVP, OCP, OPP, OTP optional yes (470 μF) yes |

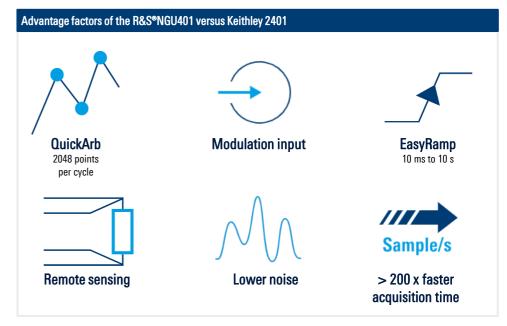






minimal overshoot, making them perfect for supplying sensitive components with power.





Rohde & Schwarz GmbH & Co. KG (www.rohde-schwarz.com)

Rohde & Schwarz customer support (www.rohde-schwarz.com/support) Rohde & Schwarz training (www.training.rohde-schwarz.com)

R&S® is a registered trademark of Rohde & Schwarz GmbH & Co. KG | PD 3609.0689.32 | Version 01.01 | February 2021 (ks)
Trade names are trademarks of the owners | R&S®NGU401 versus Keithley 2401 | Data without tolerance limits is not binding
Subject to change | © 2021 Rohde & Schwarz GmbH & Co. KG | 81671 Munich, Germany